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| Notice of References Cited | Application/Control No. 10/631,329 | Applicant(s)/Patent Under Reexamination CRUZ-URIBE ET AL. | |
| | Examiner Anh T.N. Vo | Art Unit 2861 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-4,794,463 | 12-1988 | Tamura et al. | 358/296 |
| * | B | US-5,276,459 | 01-1994 | Danzuka et al. | 346/33A |
| * | C | US-5,796,415 | 08-1998 | Inoue et al. | 347/45 |
| * | D | US-6,053,597 | 04-2000 | Hirota, Tetsuro | 347/19 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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